


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,984	LEE, WEN-CHIN	
	Examiner	Art Unit	
	Michael P. Choi	2621	

SEARCHED			
Class	Subclass	Date	Examiner
386	1,46,52,55	9/25/2007	MC
386	69,95	9/25/2007	MC
386	111-112	9/25/2007	MC
386	125-126	9/25/2007	MC
348	461,469	9/25/2007	MC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search in eDan	9/20/2007	MC
EAST Search History	9/25/2007	MC